

DATA SHEET

SURFACE MOUNT MULTILAYER CERAMIC CAPACITORS

High Frequency Automotive Grade

NP0

16 V TO 50 V 0.2 pF to 100 pF RoHS compliant & Halogen Free



YAGEO Phicomp



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SCOPE

This specification describes Automotive grade NPO series chip capacitors with lead-free terminations and used for automotive equipments.

APPLICATIONS

All general purpose applications Entertainment applications Comfort / security applications Information applications

FEATURES

- AEC-Q200 qualified
- MSL class: MSL I
- AC series soldering is compliant with J-STD-020D
- · Halogen free epoxy
- RoHS compliant
- Reduce environmentally hazardous waste
- High component and equipment reliability
- The capacitors are 100% performed by automatic optical inspection prior to taping.

ORDERING INFORMATION - GLOBAL PART NUMBER

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

GLOBAL PART NUMBER

AQ $\underline{x}\underline{x}\underline{x}\underline{x}$ \underline{x} $\underline{x}\underline{x}\underline{x}$ \underline{x} B \underline{x} $\underline{x}\underline{x}\underline{x}$

(1) (2) (3) (4) (5) (6) (7)

(I) SIZE - INCH BASED (METRIC)

0603 (1608)

(2) TOLERANCE

0.2pF to 2.0pF

 $A = \pm 0.05 pF$

 $B = \pm 0.1 pF$

 $C = \pm 0.25 \text{ pF}$

2.1pF to 5.0pF

 $A = \pm 0.05 pF$

 $B = \pm 0.1 pF$

 $C = \pm 0.25 pF$

 $D = \pm 0.5 pF$

5.1 pF to 9.9 pF

 $B = \pm 0.1 pF$

 $C = \pm 0.25 pF$

 $D = \pm 0.5 pF$

10pF and over

 $F = \pm 1\%$

 $G = \pm 2\%$

 $J = \pm 5\%$

(3) PACKING STYLE

R = Paper/PE taping reel; Reel 7 inch

P = Paper/PE taping reel; Reel 13 inch

(4) TC MATERIAL

NPO

(5) RATED VOLTAGE

7 = 16 V

8 = 25 V

9 = 50 V

(6) PROCESS

N = NP0

(7) CAPACITANCE VALUE

2 significant digits+number of zeros

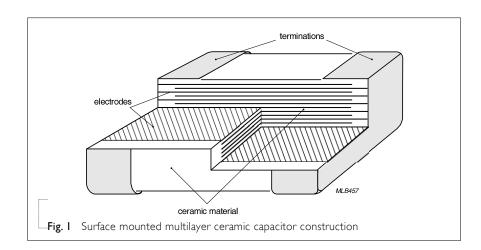
The 3rd digit signifies the multiplying factor, and letter R is decimal point

Example: $121 = 12 \times 10^{1} = 120 \text{ pF}$

CONSTRUCTION

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (Matte Sn). The terminations are leadfree. A cross section of the structure is shown in Fig.I.

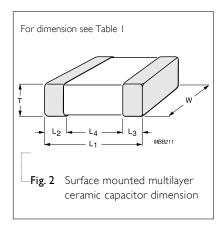


DIMENSION

Table I For outlines see fig. 2

TYPE	L _I (mm)	W (mm)	T (MM)	L ₂ / min.	L ₃ (mm) max.	L ₄ (mm) min.
0603	1.6 ±0.10	0.8 ±0.10	0.8 ±0.10	0.20	0.60	0.40

OUTLINES





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Surface-Mount Ceramic Multilayer Capacitors High Frequency Automotive grade

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CAPACITANCE RANGE & THICKNESS FOR NPO

Table 3 Size	es 0603							
CAP.	0603				CAP.	0603		
	16 V	25 V	50 V	=		16 V	25 V	50 V
0.2 pF	0.8±0.1	0.8±0.1	0.8±0.1		9 pF	0.8±0.1	0.8±0.1	0.8±0.1
0.3 pF	0.8±0.1	0.8±0.1	0.8±0.1		10 pF	0.8±0.1	0.8±0.1	0.8±0.1
0.4 pF	0.8±0.1	0.8±0.1	0.8±0.1		I2 pF	0.8±0.1	0.8±0.1	0.8±0.1
0.5 pF	0.8±0.1	0.8±0.1	0.8±0.1		15 pF	0.8±0.1	0.8±0.1	0.8±0.1
0.6 pF	0.8±0.1	0.8±0.1	0.8±0.1		18 pF	0.8±0.1	0.8±0.1	0.8±0.1
0.7 pF	0.8±0.1	0.8±0.1	0.8±0.1		22 pF	0.8±0.1	0.8±0.1	0.8±0.1
0.8 pF	0.8±0.1	0.8±0.1	0.8±0.1		27 pF	0.8±0.1	0.8±0.1	0.8±0.1
0.9 pF	0.8±0.1	0.8±0.1	0.8±0.1		33 pF	0.8±0.1	0.8±0.1	0.8±0.1
1.0 pF	0.8±0.1	0.8±0.1	0.8±0.1		39 pF	0.8±0.1	0.8±0.1	0.8±0.1
1.2 pF	0.8±0.1	0.8±0.1	0.8±0.1		47 pF	0.8±0.1	0.8±0.1	0.8±0.1
1.5 pF	0.8±0.1	0.8±0.1	0.8±0.1		56 pF	0.8±0.1	0.8±0.1	0.8±0.1
1.8 pF	0.8±0.1	0.8±0.1	0.8±0.1		68 pF	0.8±0.1	0.8±0.1	0.8±0.1
2.0 pF	0.8±0.1	0.8±0.1	0.8±0.1		82 pF	0.8±0.1	0.8±0.1	0.8±0.1
2.2 pF	0.8±0.1	0.8±0.1	0.8±0.1		100 pF	0.8±0.1	0.8±0.1	0.8±0.1
2.4 pF	0.8±0.1	0.8±0.1	0.8±0.1					
2.7 pF	0.8±0.1	0.8±0.1	0.8±0.1					
3.0 pF	0.8±0.1	0.8±0.1	0.8±0.1					
3.3 pF	0.8±0.1	0.8±0.1	0.8±0.1					
3.6 pF	0.8±0.1	0.8±0.1	0.8±0.1					
3.9 pF	0.8±0.1	0.8±0.1	0.8±0.1					
4.0 pF	0.8±0.1	0.8±0.1	0.8±0.1					
4.7 pF	0.8±0.1	0.8±0.1	0.8±0.1					
5.0 pF	0.8±0.1	0.8±0.1	0.8±0.1					
5.6 pF	0.8±0.1	0.8±0.1	0.8±0.1					
6.0 pF	0.8±0.1	0.8±0.1	0.8±0.1					
6.8 pF	0.8±0.1	0.8±0.1	0.8±0.1					
7.0 pF	0.8±0.1	0.8±0.1	0.8±0.1					
8.0 pF	0.8±0.1	0.8±0.1	0.8±0.1					
8.2 pF	0.8±0.1	0.8±0.1	0.8±0.1					

NOTE

- 1. Values in shaded cells indicate thickness class in mm
- 2. Capacitance value of non E-12 series is on request





THICKNESS CLASSES AND PACKING QUANTITY

Table 13

SIZE	THICKNESS	TAPE WIDTH -	Ø180	MM / 7 INCH	Ø330	MM / 13 INCH
CODE	CLASSIFICATION	QUANTITY PER REEL	Paper	Blister	Paper	Blister
0603	0.8 ±0.1 mm	8 mm	4,000		15,000	

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NP0

16 V to 50 V

ELECTRICAL CHARACTERISTICS

NP0 DIELECTRIC CAPACITORS; NI/SIN TERMINATIONS

Unless otherwise specified, all test and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

- Temperature: 15 °C to 35 °C - Relative humidity: 25% to 75% - Air pressure: 86 kPa to 106 kPa

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature.

The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

Table	. 14	
DESCRIP	TION	VALUE
Capacitar	nce range	0.2 pF to 100 µpF
Capacitar	nce tolerance	
NP0	C < 10 pF	±0.05 pF, ±0.1 pF, ±0.25 pF, ±0.5 pF
	C ≥ 10 pF	±1%, ±2%, ±5%
Dissipation	on factor (D.F.)	
NP0	C < 30 pF	≤ I / (400 + 20C)
	C ≥ 30 pF	≤ 0.1 %
Insulation	resistance after I minute at U _r (DC)	IR≥10 GΩ
	n capacitance change as a function of temperature ture characteristic/coefficient):	
NP0		±30 ppm/°C
Operating	g temperature range:	
NP0		−55 °C to +125 °C

16 V to 50 V

NP0

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SOLDERING RECOMMENDATION

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METHOD	SIZE 0402	0603	0805	1206	≥ 1210
Reflow	≥ 0.1 µF	≥ 1.0 µF	≥ 2.2 µF	≥ 4.7 µF	Reflow only
Reflow/Wave	< 0.1 µF	< 1.0 µF	< 2.2 µF	< 4.7 µF	

SOLDERING CONDITIONS

The lead free MLCCs are able to stand the reflow soldering conditions as below:

- Temperature: above 220 °C
- Endurance: 95 to 120 seconds
- Cycles: 3 times

The test of "soldering heat resistance" is carried out in accordance with the schedule of "MIL-STD-202F-method 210F", "The robust construction of chip capacitors allows them to be completely immersed in a solder bath of 270 °C for 10 seconds". Therefore, it is possible to mount MLCCs on one side of a PCB and other discrete components on the reverse (mixed PCBs). Surface Mount Capacitors are tested for solderability at 245 °C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds.

TESTS AND REQUIREMENTS

Table 16 Test procedures and requirements

TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS	
Mounting	IEC 60384- 21/22	4.3	The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage	
Capacitance	IEC 60384- 21/22	4.5.1	Class I: At 20 °C, 24 hours after annealing $f = 1 \text{ MHz}$ for $C \le 1 \text{ nF}$, measuring at voltage 1 V_{rms} at 20 °C	Within specified tolerance	
			f = 1 KHz for C > 1nF, measuring at voltage 1 V_{rms} at 20 $^{\circ}$ C		
Dissipation Factor (D.F.)	IEC 60384- 4.5.2 21/22		Class 1: At 20 °C, 24 hours after annealing	In accordance with specification	
			$f = 1$ MHz for $C \le InF$, measuring at voltage $1 V_{rms}$ at 20 °C		
			f = 1 KHz for C > 1nF, measuring at voltage 1 V_{rms} at 20 $^{\circ}$ C		
Insulation Resistance	IEC 60384- 21/22	4.5.3	At U _r (DC) for I minute	In accordance with specification	

NP0

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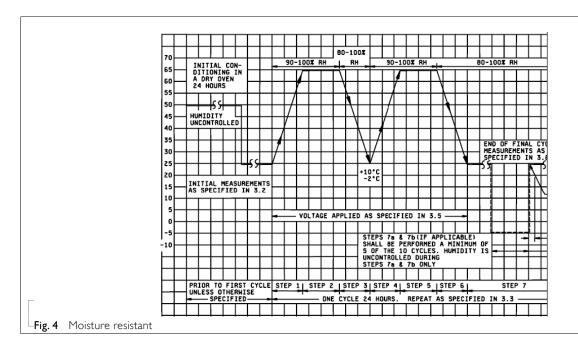
TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS
Temperature coefficient		4.6	Capacitance shall be measured by the steps shown in the following table. The capacitance change should be measured after 5 min at each specified temperature stage.	<general purpose="" series=""> Class I: Δ C/C: ±30ppm</general>
			Step Temperature(°C)	
			a 25±2	
			b Lower temperature±3°C	
			c 25±2	
			d Upper Temperature±2°C	
			e 25±2	
			(I) Class I	
			Temperature Coefficient shall be calculated from the formula as below Temp, Coefficient = $\frac{C2 - CI}{CI \times AT} \times 10^6$ [ppm/°C]	
			C1 χΔ1 C1: Capacitance at step c	
			C2: Capacitance at \$125°C	
			ΔT: 100°C(=125°C-25°C)	
			,	
			(2) Class II Capacitance Change shall be calculated from the formula as below	
			$\Delta C = \frac{C2 - C1}{C1} \times 100\%$	
			C1: Capacitance at step c C2: Capacitance at step b or d	
High	AEC-Q200	3	Unpowered ; 1000hours @ T=150°C	No visual damage
Temperature Exposure			Measurement at 24±2 hours after test conclusion.	Δ C/C :
				Class I:
				NP0: within ±0.5% or 0.5 pF whichever is greater
Temperature Cycling	AEC-Q200	4	Preconditioning; 150 +0/–10 °C for 1 hour, then keep for	No visual damage
			24 ±1 hours at room temperature	<u>Δ</u> C/C
			1000 cycles with following details	Class I:
			1000 cycles with following detail: 30 minutes at lower category temperature	NP0: Within $\pm 1\%$ or 0.5pF,
			30 minutes at upper category temperature	whichever is greater.
			Recovery time 24 ±2 hours	D.F. meet initial specified value IR meet initial specified value
Destructive	AEC-Q200	5	10ea X 3 lots.	
Physical Analysis	-		Note: Only applies to SMD ceramics. Electrical test not required.	

Surface-Mount Ceramic Multilayer Capacitors

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TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS
Moisture Resistance	AEC-Q200	6	T=24 hrs/per cycle; 10 continuous cycles unpowered. Measurement at 24 \pm 2 hours after test condition.	No visual damage
				ΔC/C NP0: Within ±3% or 3 pF, whichever is greater
				D.F. Within initial specified value
				IR NP0: ≥ 10,000 MΩ



Biased Humidity AEC-Q200

- I. Preconditioning, class 2 only: 150 +0/-10 $^{\circ}$ C /I hour, then keep for 24 \pm 1 hour at room temp
- 2. Initial measure:

Parameter: IR

Measuring voltage: I.5V \pm 0.I VDC Note: Series with 100 K Ω & 6.8 K Ω

3. Test condition:

85 °C, 85% R.H. connected with 100 K Ω resistor, applied 1.5V/U $_{r}$ for 1,000 hours.

4. Recovery:

Class 1: 6 to 24 hours Class 2: 24 ±2 hours

5. Final measure: IR

No visual damage after recovery

Initial requirement:

Class I:

- Connected to 100 K Ω :

 $C \leq$ 10 nF: I,R \geq 10,000 $M\Omega$ or

 $C > 10 \text{ nF: } (I.R-100 \text{ K}\Omega) \times C \ge 100 \text{s.}$

- Connected to 6.8 K Ω :

 $C \leq$ 10 nF: I,R \geq 10,000 M Ω or

 $C > 10 \text{ nF: } (I.R-6.8 \text{ K}\Omega) \times C \ge 100 \text{s.}$

Final measurement:

The insulation resistance shall be greater than 0.1 time initial value.

NP0 16 V to 50 V

TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS	
Operational Life	AEC-Q200	8	1. Preconditioning, class 2 only:	No visual damage	
			150 +0/-10 °C /I hour, then keep for	ΔC/C	
			24 ±1 hour at room temp	NP0: Within ±2% or 1 pF, whichever	
			2. Initial measure:	is greater	
			Spec: refer to initial spec C, D, IR		
			3. Endurance test:	D.F.	
			Specified stress voltage applied for 1,000 hours:	NP0: ≤ 2 × specified value.	
			Applied 2.0 \times U _r for general products	TVI 0. 2 2 x specified value.	
			4. Recovery time: 24 ±2 hours	IR	
			5. Final measure: C, D, IR	NP0: \geq 4,000 M Ω or IR \times C _r \geq 40s	
			5. That Meadre. C, D, IIV	whichever is less	
			Note: If the capacitance value is less than the minimum		
			value permitted, then after the other measurements		
			have been made the capacitor shall be preconditioned		
			according to "IEC 60384 4.1" and then the		
			requirement shall be met.		
External Visual	AEC-Q200	9	Any applicable method using × 10 magnification	In accordance with specification	
Physical					
Dimension	AEC-Q200	10	Verify physical dimensions to the applicable device specification.	In accordance with specification	
Mechanical	AEC-Q200	13	Three shocks in each direction shall be applied along	ΔC/C	
Shock			the three mutually perpendicular axes of the test	NP0: Within $\pm 0.5\%$ or 0.5 pF,	
			specimen (18 shocks)	whichever is greater	
			Peak value: 1,500 g's		
			Duration: 0.5 ms		
			Velocity change: 15.4 ft/s	D.F.	
			Waveform: Half-sin		Within initial specified value
				IR	
				Within initial specified value	
Vibration	AEC-Q200	14	5 g's for 20 minutes, 12 cycles each of 3 orientations.	ΔC/C	
			Note:	NP0: Within $\pm 0.5\%$ or 0.5 pF,	
			Use 8" x 5" PCB. 0.31" thick 7 secure points on one	whichever is greater	
			long side and 2 secure points at corners of opposite		
			sides. Parts mounted within 2" from any secure point.		
			Test from	D.F: meet initial specified value	
			10-2000 Hz.	IR meet initial specified value	
Resistance to	AEC-Q200	15	Precondition: I50 +0/-I0 °C for I hour, then keep for	Dissolution of the end face plating	
Soldering Heat			24 ± 1 hours at room temperature	shall not exceed 25% of the length of	
			Preheating: for size ≤ 1206: 120 °C to 150 °C for 1	the edge concerned	
			i reneating, for size \(\sigma\) [200; [20] \(\cup \text{tO} \text{[50]}\) \(\cup \text{[60]}\)	2.3 5565 55116611164	

NP0

16	٧	to	50	٧

TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS	
			minute Preheating: for size > 1206: 100 °C to 120 °C for 1 minute and 170 °C to 200 °C for 1 minute Solder bath temperature: 260 ±5 °C Dipping time: 10 ±0.5 seconds Recovery time: 24 ±2 hours	$\Delta C/C$ Class I: NP0: Within $\pm 1\%$ or 0.5 pF, whichever is greater. D.F. within initial specified value	
				IR within initial specified value	
Thermal Shock	AEC-Q200	16	 Preconditioning, class 2 only: 150 +0/-10 °C /I hour, then keep for 24 ±1 hour at a room temp Initial measure: Spec: refer to initial spec C, D, IR Rapid change of temperature test: 	No visual damage	
			NP0: -55 °C to +125 °C; 300 cycles 15 minutes at lower category temperature; 15 minutes at upper category temperature. 4. Recovery time: Class1: 6 to 24 hours Class2: 24 ±2 hours 5. Final measure: C, D, IR	D.F: meet initial specified value IR meet initial specified value	
ESD	AEC-Q200	17	Per AEC-Q200-002	A component passes a voltage level if all components stressed at that voltage level pass.	
Solderability	AEC-Q200	18	Preheated to a temperature of 80 °C to 140 °C and maintained for 30 seconds to 60 seconds. Test conditions for lead containing solder alloy Temperature: 235 ±5 °C Dipping time: 2 ±0.2 seconds Depth of immersion: 10 mm Alloy Composition: 60/40 Sn/Pb Number of immersions: I Test conditions for lead-free containing solder alloy Temperature: 245 ±5 °C Dipping time: 3 ±0.3 seconds Depth of immersion: 10 mm Alloy Composition: SAC305 Number of immersions: I	The solder should cover over 95% of the critical area of each termination.	
Electrical Characterization	AEC-Q200	19	Parametrically test per lot and sample size requirements, summary to show Min, Max, Mean and Standard deviation at room as well as Min and Max operating temperatures. Class I: NP0: -55 °C to +125 °C Normal temperature: 20 °C	ΔC/C Class I: NP0: ±30 ppm/°C	

High Frequency Automotive grade

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16 V to 50 V

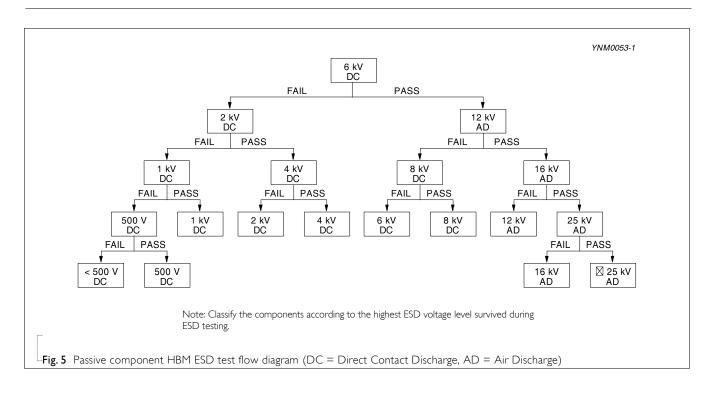
TEST TEST METHOD PROCEDURE REQUIREMENTS Board Flex AEC-Q200 21 Part mounted on a 100 mm X 40 mm FR4 PCB board, No visible damage which is 1.6 ±0.2 mm thick and has a layer-thickness 35 $\mu m \pm 10 \mu m$. ΔC/C Part should be mounted using the following soldering Class I: reflow profile. NP0: Within $\pm 1\%$ or 0.5 pF, Conditions: whichever is greater Class I: Bending 3 mm at a rate of 1 mm/s, radius jig 340 mm Test Substrate: Dimension(mm) Type b С ΥN Ф4.5 0201 0.3 0.9 0.3 0402 1.5 0.5 0603 1.0 3.0 12 1.65 0805 1.2 4.0 а 1206 2.2 5.0 1.65 100 1210 2.2 5.0 2.0 unit: mm 1808 3.5 7.0 3.7 **Terminal** AEC-Q200 22 With the component mounted on a PCB obtained Magnification of 20X or greater may Strength with the device to be tested, apply a 17.7N (1.8Kg) be employed for inspection of the force to the side of a device being tested. mechanical integrity of the device This force shall be applied for 60+1 seconds. body, terminals and body/terminal Also the force shall be applied gradually as not to apply junction. a shock to the component being tested. Before, during and after the test, the device shall comply with all electrical * Apply 2N force for 0402 size. requirements stated in this specification. Beam Load Test AEC-Q200 23 ≤ 0805 Place the part in the beam load fixture. Apply a force Thickness > 0.5mm: 20N until the part breaks or the minimum acceptable force level required in the user specification(s) is attained. Thickness ≤ 0.5mm: 8N ≥ 1206 Thickness ≥1.25 mm: 54N Thickness < 1.25 mm: 15N Voltage Proof 1. Specified stress voltage applied for 1~5 seconds No breakdown or flashover 2. Ur ≤ 100 V: series applied 2.5 Ur 3. $100 \text{ V} < \text{Ur} \le 200 \text{ V}$ series applied (1.5 Ur + 100) 4. 200 V < Ur ≤ 500 V series applied (1.3 Ur + 100) 5. Ur > 500 V: 1.3 Ur

6. Ur ≥ 1000 V: 1.2 Ur

Charge/Discharge current is less than 50 mA

16 V to 50 V NP0

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS
ESR		Measuring frequency: I ± 0.2GHz at room	0.2pF≤ C≤ IpF: 350mΩ / C max
		temperature.	lpF < C ≤ 5pF:300mΩ max
			$5pF < C \le 10pF : 250m\Omega$ max
			C : Nominal cap (pF)
		Measuring frequency: 500 ± 50 MHz at room temperature.	10pF < C ≤ 100pF :400mΩ max



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Surface-Mount Ceramic Multilayer Capacitors High Frequency Automotive grade

16 V to 50 V

Product specification 14

REVISION HISTORY

REVISION DATE **CHANGE NOTIFICATION DESCRIPTION**

Version 0 Dec. 14, 2018 -- New

NP0

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NMC0402X7R153K16TRPF NMC0603NPO330G50TRPF NMC0603NPO331F50TRPF NMC0603X5R475M6.3TRPF

NMC0805NPO220J100TRPF NMC0805NPO270J50TRPF NMC0805NPO681F50TRPF NMC0805NPO820J50TRPF

NMC1206X7R102K50TRPF NMC1210Y5V105Z50TRPLPF NMC-H0805X7R472K250TRPF NMC-L0402NPO7R0C50TRPF NMC-L0603NPO2R2B50TRPF NMC-Q0402NPO8R2D200TRPF C1206C101J1GAC C1608C0G2A221J C1608X7R1E334K C2012C0G2A472J

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CGA2B2C0G1H3R3C CGA2B2C0G1H680J CGA2B2C0G1H6R8D CGA2B2C0G1H820J CGA2B2X8R1H152K